FORM PTO 4440 SEP	1 6 5002 PR	Page		of <u>1</u>		
FORM PTO-1449	U.S. SEPARTMENT OF COMMERCE	Atty. [	Docket No.:	Appl'n No.:		
(Rev 8/83)	U.S. SEPARTMENT OF COMMERCE PARENT AND TRADEMARK OFFICE PADEMARK	EL	G056-US	10/720,421		
61	RADEM		Applicant:			
INFORMATION DISCLOSURE STATEMENT			Kent et al.			
		Fili	ing Date:	Group:		
(Use	several sheets if necessary)	Nov	. 24, 2003	2673		

## **US PATENT DOCUMENTS**

* Exr.	Document	5-1-	N	01	Sub-	Filing date (if
initial	number	Date	Name	Class	class	appropriate)
	4,680,430 A	07/14/1987	Yoshikawa et al.	178	19	
	4,687,885 A	08/18/1987	Talmage, Jr., et al.	178	18	
	5,250,388 A	10/05/1993	Schoch, Jr., et al.	430	269	
	5,892,244 A	04/06/1999	Tanaka et al.	257	40	
	6,204,515	03/20/2001	Bernius et al.	257	40	
	2001/043291 A1	11/22/2001	Kono et al.	349	12	
	6,596,569 B1	07/22/2003	Bao et al.	438	151	

## **FOREIGN PATENT DOCUMENTS**

* Exr. initial	Document number	Date	Country	Class	Sub- class	Translation enclosed (?)
	0 097 368 A	01/04/1984	Europe	G06K	11/06	
			1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

Exr.		Translation
initial	Details of Document	enclosed (?)
	International Search Report for International Application No. PCT/US2004/038348, dated July 21, 2005.	
	International Search Report for International Application No. PCT/US2004/038349, dated July 21, 2005.	
	Richard Friend et al., "Polymer Diodes", <u>Physics World</u> , Bristol, Great Britain, vol. 12, no. 6, June 1999, pages 35-40.	
	L.S. Roman et al., <u>Appl. Phys. Lett.</u> , vol. 75, 1999, pages 3557-3559.	
	G. Greczynski et al., Thin Solid Films, vol. 354, 1999, pages 129-135.	
	L.S. Roman et al., Synth. Metals, vol. 125, 2002, pages 419-422.	
	Patent Abstracts of Japan, vol. 008, no. 190 (E-263), 31 August 1984 & Japanese Publication No. JP 59-078584 A (Toshiba KK), 7 May 1984 (abstract only)	

_	
<u> </u>	
Examiner's signature	Date considered
Laminer 3 Signature	Date considered

<sup>\*</sup> EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.